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# INTERNATIONAL STANDARD

# IEC 61131-2

Third edition  
2007-07

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## Programmable controllers – Part 2: Equipment requirements and tests



Commission Electrotechnique Internationale  
International Electrotechnical Commission  
Международная Электротехническая Комиссия

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## INTERNATIONAL ELECTROTECHNICAL COMMISSION

### PROGRAMMABLE CONTROLLERS –

### Part 2: Equipment requirements and tests

#### FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as “IEC Publication(s)”). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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International Standard IEC 61131-2 has been prepared by subcommittee 65B: Devices, of IEC technical committee 65: Industrial-process measurement and control.

This third edition of IEC 61131-2 cancels and replaces the second edition published in 2003 and constitutes a technical revision.

This third edition includes the following significant technical changes with respect to the previous edition.

- a) DC power port requirements have been moved from Clause 8 to Clause 5.
- b) Correction of the following tests of Clause 6:
  - voltage range test;
  - fast supply voltage variation test;
  - slow supply voltage variation test;
  - gradual shut-down/start-up test.
- c) Change of EMC requirements in Clause 8:

- requirements for radiofrequency interference in Table 33 changed from 3 V to 10 V for Zone B equipment;
  - reference to EMC basic standards with the last version;
  - reference to generic standards 61000-6-x;
  - cable length aligned to generic standards.
- d) Correction of the following tests in Clause 9:
- voltage dips and interruptions – power port type tests and verifications.
- e) New organization of Clause 11:
- equipment types and protection;
  - open PLC-system equipment;
  - enclosed PLC-system equipment:
    - Class I equipment;
    - Class II equipment;
    - Class III equipment;
  - protection against electric shock;
  - definition of secondary circuits which do not pose a risk of electric shock:
    - Class 2 circuit;
    - limited voltage/current circuit;
    - limited voltage circuit;
    - limited energy circuit  $\leq 30$  V a.c. or 42,2 V peak;
    - limited impedance circuit;
  - protection against the spread of fire within limited power circuits;
  - protective earthing requirements for enclosed equipment;
  - minor improvements in different subclauses;
  - impulse test only for verification of clearances.

The text of this standard is based on the following documents:

FDIS	Report on voting
65B/623/FDIS	65B/636/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The list of all parts of the IEC 61131 series, under the general title *Programmable controllers*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.

## INTRODUCTION

IEC 61131-2 is part of a series of standards on programmable controllers and the associated peripherals and should be read in conjunction with the other parts of the series.

Where a conflict exists between this and other IEC standards (except basic safety standards), the provisions of this standard should be considered to govern in the area of programmable controllers and their associated peripherals.

Compliance with IEC 61131-2 cannot be claimed unless the requirements of 7.2 are met.

Service and physical environment requirements are specified in Clause 4. Functional requirements are specified in Clause 5. Electromagnetic compatibility requirements are specified in Clause 8. Safety requirements are specified in Clause 11.

Terms of general use are defined in IEC 61131-1. More specific terms are defined in each part.

## PROGRAMMABLE CONTROLLERS –

### Part 2: Equipment requirements and tests

#### 1 General

##### 1.1 Scope and object

This part of IEC 61131 specifies requirements and related tests for programmable controllers (PLCs) and their associated peripherals (for example, programming and debugging tools (PADTs), human-machine interfaces (HMIs), etc.) which have as their intended use the control and command of machines and industrial processes.

PLCs and their associated peripherals are intended to be used in an industrial environment and may be provided as open or enclosed equipment. If a PLC or its associated peripherals are intended for use in other environments (light industrial, commercial, residential), then the specific requirements, standards and installation practices for those other environments should be additionally applied to the PLC and its associated peripherals.

This standard also applies to any products performing the function of PLCs and/or their associated peripherals.

Equipment covered in this standard is intended for use in overvoltage category II (IEC 60664-1) in low-voltage installations, where the rated equipment supply voltage does not exceed a.c. 1 000 V r.m.s. (50/60 Hz), or d.c. 1 500 V. (If PLCs or their associated peripherals are applied in overvoltage category III installations, then additional analysis will be required to determine the suitability of the equipment for those applications.)

This standard does not deal with the functional safety or other aspects of the overall automated system. PLCs, their application programme and their associated peripherals are considered as components of a control system.

Since PLCs are component devices, safety considerations for the overall automated system including installation and application are beyond the scope of this standard. Refer to IEC 60364-1 or applicable national/local regulations for electrical installation and guidelines.

However, PLC safety as related to electric shock and fire hazards, electrical interference immunity and error detecting of the PLC-system operation (such as the use of parity checking, self-testing diagnostics, etc.), are addressed.

The object of this standard is

- to establish the definitions and identify the principal characteristics relevant to the selection and application of PLCs and their associated peripherals;
- to specify the minimum requirements for functional, electrical, mechanical, environmental and construction characteristics, service conditions, safety, EMC, user programming and tests applicable to PLCs and the associated peripherals.

This standard also specifies

- a) service, storage and transportation requirements for PLCs and their associated peripherals (Clause 4);
- b) functional requirements for PLCs and their associated peripherals (Clause 5);
- c) EMC requirements for PLCs and their associated peripherals (Clause 8);

- d) safety requirements for PLCs and their associated peripherals (Clause 11);
- e) information that the manufacturer is required to supply (Clauses 7, 10 and 14);
- f) test methods and procedures that are to be used for the verification of compliance of PLCs and their associated peripherals with the requirements (Clauses 6, 9 and 12).
- g) safety routine tests for PLCs and their peripherals (Clause 13).

The tests are type tests or production routine tests, and not tests related to the ways PLC systems are applied.

## 1.2 Compliance with this standard

When compliance with this standard is indicated without qualification, compliance with all clauses, including all tests and verifications required in this standard, should be verified. Moreover, the manufacturer's obligations expressed in this standard are not waived if no type test is required, or if the test conditions are restricted for practical reasons.

When compliance with some portion of this standard is indicated, it is only necessary to verify compliance with those clauses against which the compliance claim is made. The manufacturer's obligations as indicated above are still applicable. The smallest unit of this standard for compliance purposes should be a clause, such as Clauses 5, 8 or 11.

Compliance with a portion of this standard is provided to facilitate efforts with respect to particular conformity assessment requirements (for example, Clause 8, 9 and 10 as the compliance requirements for the EU electromagnetic compatibility directive or Clause 11, 12, 13 and 14 as the compliance requirements for the EU low-voltage directive).

Compliance with constructional requirements and with requirements for information to be provided by the manufacturer should be verified by suitable examination, visual inspection and/or measurement.

All requirements not tested according to the clauses on tests and verifications should be verifiable under a procedure to be agreed to by the manufacturer and the user.

The manufacturer shall provide, on request, compliance verification information for all requirements referenced in the claims of compliance with all or a portion of this standard.

It is the manufacturer's responsibility to ensure that delivered PLC equipment and associated peripherals are equivalent to the sample(s) which have been type-tested according to this standard and therefore that they comply with all requirements of this standard.

Significant modifications shall be indicated through the use of suitable revision level indexes and markings (see 5.11 and 11.15) and shall comply with this standard.

NOTE A new type test may be required to confirm compliance.

Where the manufacturer is allowed to select among several options, he shall clearly specify in his catalogues and/or datasheets those to which any portion of the PLC-system equipment complies. This applies to severity classes of voltage dips (i.e. PS1 or PS2) and types of digital inputs (i.e. Type 1 or Type 3).

## 1.3 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60060-1:1992, *High-voltage test techniques – Part 1: General definitions and test requirements*

IEC 60068-2-1:2007, *Environmental testing – Part 2-1: Tests – Test A: Cold*

IEC 60068-2-2:1974, *Environmental testing – Part 2: Tests – Tests B: Dry heat*

IEC 60068-2-6:1995, *Environmental testing – Part 2: Tests – Test Fc: Vibration (sinusoidal)*

IEC 60068-2-14:1984, *Environmental testing – Part 2: Tests – Test N: Change of temperature*

IEC 60068-2-27:1987, *Environmental testing – Part 2: Tests – Test Ea and guidance: Shock*

IEC 60068-2-30:2005, *Environmental testing – Part 2: Tests – Test Db: Damp heat, cyclic (12 h + 12-hour cycle)*

IEC 60068-2-31:1969, *Environmental testing – Part 2: Tests – Test Ec: Drop and topple, primarily for equipment-type specimens*

IEC 60068-2-32:1975, *Environmental testing – Part 2: Tests – Test Ed: Free fall*

IEC 60364-1:2005, *Low-voltage electrical installations – Part 1: Fundamental principles, assessment of general characteristics, definitions*

IEC 60364-4-41:2005, *Low-voltage electrical installations – Part 4-41: Protection for safety – Protection against electric shock*

IEC 60417, *Graphical symbols for use on equipment*

IEC 60529:2001, *Degrees of protection provided by enclosures (IP Code)*<sup>1</sup>  
Amendment 1 (1999)

IEC 60664-1:1992, *Insulation coordination for equipment within low-voltage systems – Part 1: Principles, requirements and tests*<sup>2</sup>

Amendment 1 (2000)

Amendment 2 (2002)

IEC 60664-3:2003, *Insulation coordination for equipment within low-voltage systems – Part 3: Use of coating, potting or moulding for protection against pollution*

IEC 60695-2-11:2000, *Fire hazard testing – Part 2-11: Glowing/hot-wire based test methods – Glow-wire flammability test method for end-products*

IEC 60695-11-10:1999, *Fire hazard testing – Part 11-10: Test flames – 50 W horizontal and vertical flame test methods*

IEC 60947-5-1:2003, *Low-voltage switchgear and controlgear – Part 5-1: Control circuit devices and switching elements – Electromechanical control circuit devices*

IEC 60947-5-2:2004, *Low-voltage switchgear and controlgear – Part 5-2: Control circuit devices and switching elements – Proximity switches*

IEC 60947-7-1:2002, *Low-voltage switchgear and controlgear – Part 7-1: Ancillary equipment – Terminal blocks for copper conductors*

IEC 60950-1:2001, *Information technology equipment – Safety – Part 1: General requirements*

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<sup>1</sup> There exists a consolidated edition 2.1 that includes edition 2.0 (2001) and its amendment.

<sup>2</sup> There exists a consolidated edition 1.2 that includes edition 1.0 (1992) and its amendments.

IEC 61000-4-2:1995, *Electromagnetic compatibility (EMC) – Part 4-2: Testing and measurement techniques – Electrostatic discharge immunity test*

IEC 61000-4-3:2006, *Electromagnetic compatibility (EMC) – Part 4-3: Testing and measurement techniques – Radiated radio-frequency electromagnetic field immunity test*

IEC 61000-4-4:2004, *Electromagnetic compatibility (EMC) – Part 4: Testing and measurement techniques – Section 4: Electrical fast transient/burst immunity test*

IEC 61000-4-5:2005, *Electromagnetic compatibility (EMC) – Part 4-5: Testing and measurement techniques – Surge immunity test*

IEC 61000-4-6:2003, *Electromagnetic compatibility (EMC) – Part 4-6: Testing and measurement techniques – Immunity to conducted disturbances induced by radio-frequency fields*

IEC 61000-4-8:1993, *Electromagnetic compatibility (EMC) – Part 4-8: Testing and measurement techniques – Power frequency magnetic field immunity test*

IEC 61000-4-11:2004, *Electromagnetic compatibility (EMC) – Part 4-11: Testing and measurement techniques – Voltage dips, short interruptions and voltage variations immunity test*

IEC 61000-4-18:2006, *Electromagnetic compatibility (EMC) – Part 4-18: Testing and measurement techniques – Damped oscillatory waves immunity test*

IEC 61000-4-29:2000, *Electromagnetic compatibility (EMC) – Part 4-29: Testing and measurement techniques – Voltage dips, short interruptions and voltage variations on d.c. input power port immunity test*

IEC 61000-6-1:2005, *Electromagnetic compatibility (EMC) – Part 6-1: Generic standards – Immunity for residential, commercial and light-industrial environments*

IEC 61000-6-2:2005, *Electromagnetic compatibility (EMC) – Part 6-2: Generic standards – Immunity for industrial environments*

IEC 61000-6-4:2006, *Electromagnetic compatibility (EMC) – Part 6-4: Generic standards – Emission standard for industrial environments*

IEC 61010-1:2001, *Safety requirements for electrical equipment for measurement, control, and laboratory use – Part 1: General requirements*

IEC 61131-1:2003, *Programmable controllers – Part 1: General information*

IEC 61131-3:2003, *Programmable controllers – Part 3: Programming languages*

IEC 61131-4:2004, *Programmable controllers – Part 4: User guidelines*

CISPR 14-1:2005, *Electromagnetic compatibility – Requirements for household appliances, electric tools and similar apparatus – Part 1: Emission*

CISPR 16-1-2:2003, *Specification for radio disturbance and immunity measuring apparatus and methods – Part 1-2: Radio disturbance and immunity measuring apparatus – Ancillary equipment – Conducted disturbances*

CISPR 16-1-4:2004, *Specification for radio disturbance and immunity measuring apparatus and methods – Part 1-4: Radio disturbance and immunity measuring apparatus – Ancillary equipment – Radiated disturbances*

CISPR 16-2-1:2005, *Specification for radio disturbance and immunity measuring apparatus and methods – Part 2-1: Methods of measurement of disturbances and immunity – Conducted disturbance measurements*

CISPR 16-2-3:2006, *Specification for radio disturbance and immunity measuring apparatus and methods – Part 2-3: Methods of measurement of disturbances and immunity – Radiated disturbance measurements*